

Complementary Silicon Plastic Power Transistors

... designed for use in general purpose amplifier and switching applications.

• Collector–Emitter Saturation Voltage —

 $V_{CE} = 1.2 \text{ Vdc (Max)} @ I_{C} = 3.0 \text{ Adc}$

• Collector-Emitter Sustaining Voltage —

V_{CEO(sus)} = 100 Vdc (Min.) BD241C, BD242C

• High Current Gain — Bandwidth Product

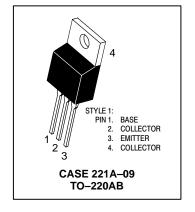
 $f_T = 3.0 \text{ MHz (Min)} @ I_C = 500 \text{ mAdc}$

• Compact TO-220 AB Package

BD241C* PNP BD242C*

*ON Semiconductor Preferred Device

3 AMPERE
POWER TRANSISTORS
COMPLEMENTARY
SILICON
80, 100 VOLTS
40 WATTS



MAXIMUM RATINGS

Rating	Symbol	BD241C BD242C	Unit
Collector–Emitter Voltage	VCEO	100	Vdc
Collector–Emitter Voltage	VCES	115	Vdc
Emitter-Base Voltage	VEB	5.0	Vdc
Collector Current — Continuous Peak	IC	3.0 5.0	Adc Adc
Base Current	IB	1.0	Adc
Total Device Dissipation @ T _C = 25°C Derate above 25°C	PD	40 0.32	Watts W/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	62.5	°C/W
Thermal Resistance, Junction to Case	$R_{ heta JC}$	3.125	°C/W

Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

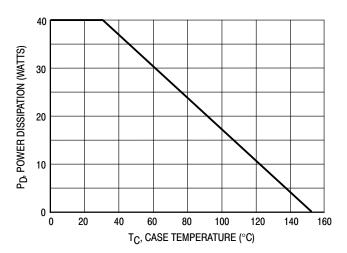


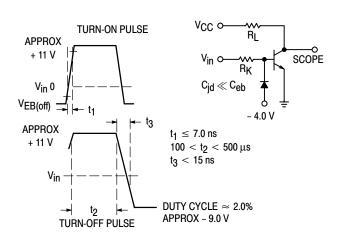
Figure 1. Power Derating

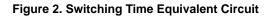
ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic		Symbol	Min.	Max.	Unit
OFF CHARACTERISTICS					
Collector–Emitter Sustaining Voltage ¹ (I _C = 30 mAdc, I _B = 0)	BD241C, BD242C	VCEO	100		Vdc
Collector Cutoff Current (V _{CE} = 60 Vdc, I _B = 0)	BD241C, BD242C	ICEO		0.3	mAdc
Collector Cutoff Current (V _{CE} = 100 Vdc, V _{EB} = 0)	BD241C, BD242C	ICES		200	μAdc
Emitter Cutoff Current (VBE = 5.0 Vdc, I _C = 0)		I _{EBO}		1.0	mAdc
ON CHARACTERISTICS ¹					
DC Current Gain (I _C = 1.0 Adc, V _{CE} = 4.0 Vdc) (I _C = 3.0 Adc, V _{CE} = 4.0 Vdc)		hFE	25 10		
Collector–Emitter Saturation Voltage (I _C = 3.0 Adc, I _B = 600 Adc)		VCE(sat)		1.2	Vdc
Base–Emitter On Voltage (I _C = 3.0 Adc, V _{CE} = 4.0 Vdc)		V _{BE} (on)		1.8	Vdc
DYNAMIC CHARACTERISTICS					
Current Gain – Bandwidth Product ² (I _C = 500 mAdc, V _{CE} = 10 Vdc, f _{test} = 1 MHz)		fΤ	3.0		MHz
Small–Signal Current Gain (IC = 0.5 Adc, VCE = 10 Vdc, f = 1 kHz)		h _{fe}	20		

¹ Pulse Test: Pulse Width $\leq 300 \,\mu\text{s}$, Duty Cycle $\leq 2.0\%$.

² $f_T = |h_{fe}| \cdot f_{test}$





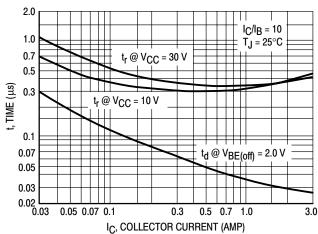


Figure 3. Turn-On Time

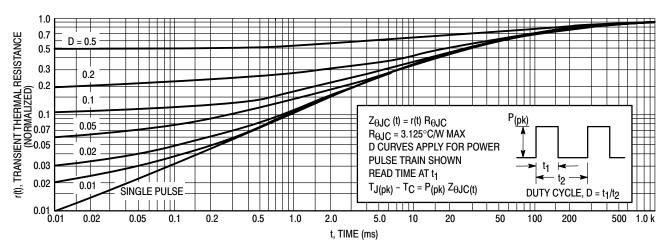


Figure 4. Thermal Response

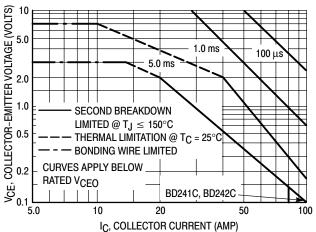


Figure 5. Active Region Safe Operating Area

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation, i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 5 is based on $T_{J(pk)} = 150^{\circ}C$; T_{C} is variable depending on conditions. Second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J(pk)} \le 150^{\circ}C$, $T_{J(pk)}$ may be calculated from the data in Figure 4. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

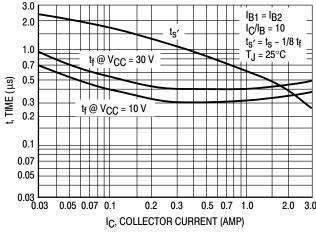


Figure 6. Turn-Off Time

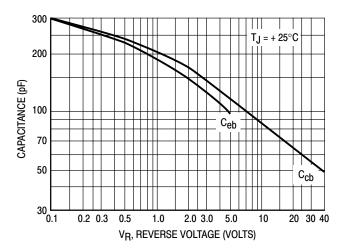


Figure 7. Capacitance

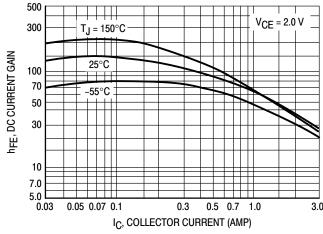


Figure 8. DC Current Gain

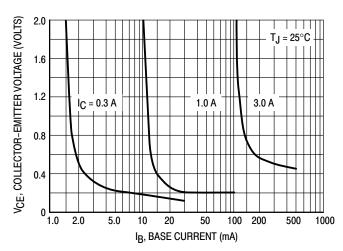


Figure 9. Collector Saturation Region

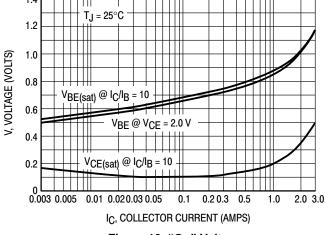


Figure 10. "On" Voltages

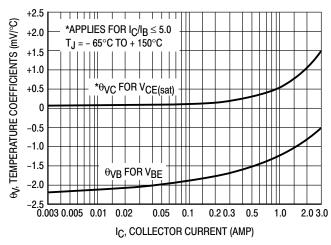


Figure 11. Temperature Coefficients

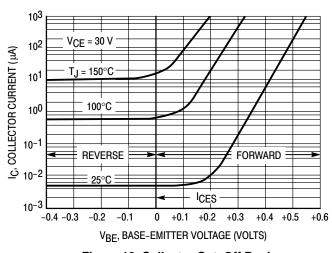


Figure 12. Collector Cut-Off Region

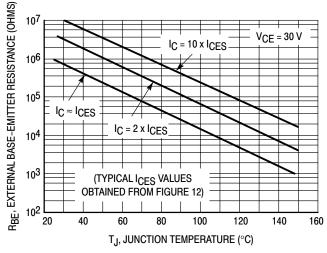
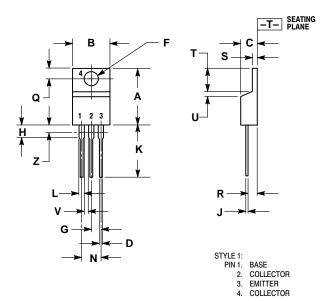


Figure 13. Effects of Base-Emitter Resistance

PACKAGE DIMENSIONS

TO-220AB **CASE 221A-09 ISSUE AB**



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04



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